

**High speed 650V Field Stop Trench IGBT co-packed with fast and soft recovery anti-parallel diode**

<b>V<sub>CE</sub></b>	<b>650 V</b>	<b>I<sub>c</sub></b>	<b>40 A</b>
<b>V<sub>CEsat</sub></b>	<b>1.65 V</b>	<b>E<sub>OFF</sub></b>	<b>0.39 mJ</b>

**Features**

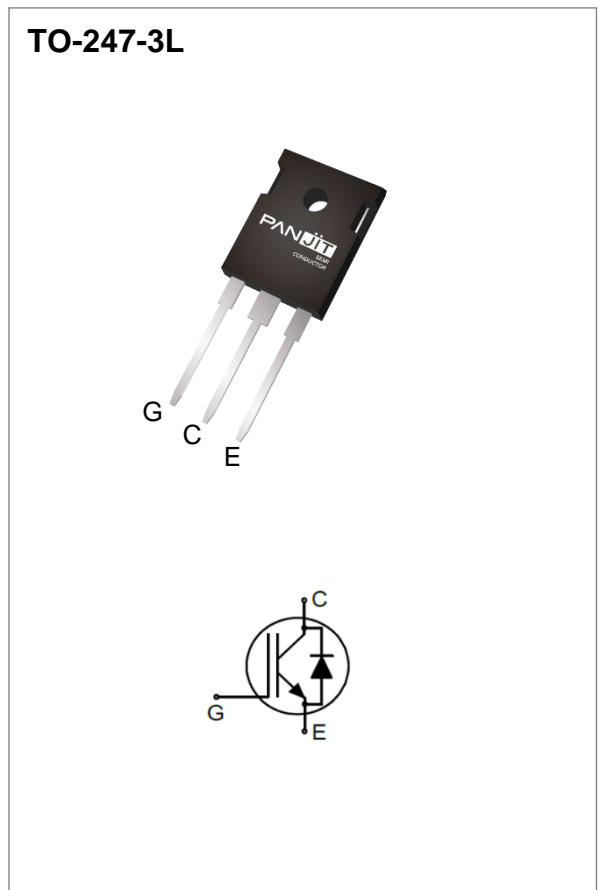
- Superior high speed switching IGBT
- Low saturation voltage 1.65V at T<sub>VJ</sub> 25 °C
- Co-packed with low Q<sub>rr</sub> and soft recovery diode
- Maximum junction temperature T<sub>VJ</sub> 175 °C
- Easy paralleling usage due to positive coefficient V<sub>CEsat</sub>
- Lead free in compliance with EU RoHS 2.0
- Green molding compound as per IEC 61249 standard

**Mechanical Data**

- Case: TO-247-3L molded plastic
- Terminals: Solderable per MIL-STD-750, Method 2026
- Approx. Weight: 6.157grams

**Application**

- UPS
- PV Inverter
- EV Charger
- Welding machine
- Home appliance



**Maximum Ratings**

PARAMETER	SYMBOL	LIMIT	UNITS
Collector-Emitter Voltage	V <sub>CE</sub>	650	V
Gate-Emitter Voltage	V <sub>GE</sub>	± 20	V
DC Collector Current @ T <sub>C</sub> = 25°C	I <sub>c</sub>	76	A
DC Collector Current @ T <sub>C</sub> = 100°C	I <sub>c</sub>	46	A
Pulsed Collector Current, t <sub>P</sub> limited by T <sub>VJmax</sub>	I <sub>Cpulse</sub>	120	A
Turn-off safe operating area V <sub>CC</sub> ≤ 400 V, V <sub>CE,peak</sub> < 650 V, V <sub>GE</sub> = 0/15 V, R <sub>Goff</sub> ≥ 10 Ω, T <sub>VJ</sub> ≤ 175 °C	-	120	A
Diode Forward Current @ T <sub>C</sub> = 25°C	I <sub>F</sub>	40	A
Diode Forward Current @ T <sub>C</sub> = 100°C	I <sub>F</sub>	20	A

PARAMETER	SYMBOL	LIMIT	UNITS
Pulsed Diode Current, $t_p$ limited by $T_{VJmax}$	$I_{Fpulse}$	120	A
Power Dissipation @ $T_C = 25^\circ C$	$P_{total}$	220	W
Power Dissipation @ $T_C = 100^\circ C$		110	
Operating Junction Temperature Range	$T_{VJ}$	-40 to +175	$^\circ C$
Storage Temperature Range	$T_{STG}$	-55 to +150	$^\circ C$
Soldering Temperature, 1/8" from case for 5 seconds	$T_{SLD}$	260	$^\circ C$

### Typical Ratings

PARAMETER	SYMBOL	TYP.	UNITS
Non-Repetitive Forward Surge Current (Half-Sine Pulse, $t_p = 8.3$ ms, $T_C = 25^\circ C$ )	$I_{FM}$	350	A
(Half-Sine Pulse, $t_p = 8.3$ ms, $T_C = 150^\circ C$ )		295	
Internal emitter inductance measured 5mm(0.197 in.) from case	$L_E$	13	nH

### Thermal Resistance

PARAMETER	SYMBOL	CONDITION	MIN.	TYP.	MAX.	UNITS
Thermal Resistance Junction to Case, for IGBT	$R_{\theta JC}$	-	-	-	0.68	$^\circ C/W$
Thermal Resistance Junction to Case, for Diode	$R_{\theta JC}$	-	-	-	0.68	$^\circ C/W$
Thermal Resistance Junction to Ambient	$R_{\theta JA}$	-	-	-	40	$^\circ C/W$

**Electrical Characteristics** ( $T_{VJ} = 25\text{ }^{\circ}\text{C}$  unless otherwise specified)

PARAMETER	SYMBOL	TEST CONDITION	MIN.	TYP.	MAX.	UNITS
-----------	--------	----------------	------	------	------	-------

**Static Characteristic**

Collector-Emitter Breakdown Voltage	$V_{(BR)CES}$	$V_{GE} = 0V, I_C = 0.5mA$	650	-	-	V
Collector-Emitter Saturation Voltage	$V_{CEsat}$	$V_{GE} = 15V, I_C = 40A$ $T_{VJ} = 25\text{ }^{\circ}\text{C}$ $T_{VJ} = 125\text{ }^{\circ}\text{C}$ $T_{VJ} = 175\text{ }^{\circ}\text{C}$	-	1.65	2.25	
Gate-Emitter Threshold Voltage	$V_{GE(th)}$	$I_C = 40mA, V_{CE} = V_{GE}$	3.0	4.5	6.0	V
Collector-Emitter Cut Off Current	$I_{CES}$	$V_{GE} = 0V, V_{CE} = 650V$	-	-	80	$\mu A$
Gate-Emitter Leakage Current	$I_{GES}$	$V_{GE} = 20V, V_{CE} = 0V$	-	-	200	nA
Transconductance	$g_{fs}$	$V_{CE} = 20V, I_C = 40A$	-	29	-	S

**Dynamic Characteristic**

Input Capacitance	$C_{ies}$	$V_{CE} = 25V, V_{GE} = 0V$ $f = 1MHz$	-	1840	-	pF
Output Capacitance	$C_{oes}$		-	95	-	
Reverse Transfer Capacitance	$C_{res}$		-	13	-	
Gate Charge	$Q_G$	$V_{CE} = 520V, I_C = 40A$ $V_{GE} = 15V$	-	65	-	nC

**Switching Characteristic, Inductive Load**

Turn-On Delay Time	$t_{d(on)}$	$T_{VJ} = 25\text{ }^{\circ}\text{C}$ $V_{CC} = 400V, I_C = 20A$ $V_{GE} = 0 / 15V$ $R_G = 10\Omega$	-	14	-	ns
Rise Time	$t_r$		-	14	-	ns
Turn-Off Delay Time	$t_{d(off)}$		-	96	-	ns
Fall Time	$t_f$		-	16	-	ns
Turn-On Energy	$E_{on}$		-	0.33	-	mJ
Turn-Off Energy	$E_{off}$		-	0.12	-	mJ
Total Switching Energy	$E_{ts}$		-	0.45	-	mJ
Turn-On Delay Time	$t_{d(on)}$	$T_{VJ} = 25\text{ }^{\circ}\text{C}$ $V_{CC} = 400V, I_C = 40A$ $V_{GE} = 0 / 15V$ $R_G = 10\Omega$	-	15	-	ns
Rise Time	$t_r$		-	31	-	ns
Turn-Off Delay Time	$t_{d(off)}$		-	86	-	ns
Fall Time	$t_f$		-	38	-	ns
Turn-On Energy	$E_{on}$		-	0.75	-	mJ
Turn-Off Energy	$E_{off}$		-	0.39	-	mJ
Total Switching Energy	$E_{ts}$		-	1.14	-	mJ

Turn-On Delay Time	$t_{d(on)}$	$T_{VJ} = 175^{\circ}\text{C}$ $V_{CC} = 400\text{V}, I_C = 20\text{A}$ $V_{GE} = 0 / 15\text{V}$ $R_G = 10\Omega$	-	13	-	ns
Rise Time	$t_r$		-	14	-	ns
Turn-Off Delay Time	$t_{d(off)}$		-	123	-	ns
Fall Time	$t_f$		-	17	-	ns
Turn-On Energy	$E_{on}$		-	0.59	-	mJ
Turn-Off Energy	$E_{off}$		-	0.22	-	mJ
Total Switching Energy	$E_{ts}$		-	0.81	-	mJ
Turn-On Delay Time	$t_{d(on)}$	$T_{VJ} = 175^{\circ}\text{C}$ $V_{CC} = 400\text{V}, I_C = 40\text{A}$ $V_{GE} = 0 / 15\text{V}$ $R_G = 10\Omega$	-	15	-	ns
Rise Time	$t_r$		-	31	-	ns
Turn-Off Delay Time	$t_{d(off)}$		-	103	-	ns
Fall Time	$t_f$		-	33	-	ns
Turn-On Energy	$E_{on}$		-	1.21	-	mJ
Turn-Off Energy	$E_{off}$		-	0.49	-	mJ
Total Switching Energy	$E_{ts}$		-	1.70	-	mJ

**Diode Characteristic**

Diode Forward Voltage	$V_F$	$V_{GE} = 0\text{V}, I_F = 20\text{A}$ $T_{VJ} = 25^{\circ}\text{C}$ $T_{VJ} = 125^{\circ}\text{C}$ $T_{VJ} = 175^{\circ}\text{C}$	-	1.60	-	V
Reverse Recovery Time	$t_{rr}$	$I_F = 20\text{A}, V_R = 400\text{V},$ $di/dt = 1000\text{A}/\mu\text{s},$ $T_{VJ} = 25^{\circ}\text{C}$	-	64	-	ns
Reverse Recovery Charge	$Q_{rr}$		-	400	-	nC
Reverse Recovery Current	$I_{rrm}$		-	13	-	A
Reverse Recovery Energy	$E_{rec}$		-	56	-	$\mu\text{J}$
Diode peak rate of fall of reverse recovery current	$dI_{rr}/dt$		-	597	-	$\text{A}/\mu\text{s}$
Reverse Recovery Time	$t_{rr}$	$I_F = 20\text{A}, V_R = 400\text{V},$ $di/dt = 1000\text{A}/\mu\text{s},$ $T_{VJ} = 175^{\circ}\text{C}$	-	80	-	ns
Reverse Recovery Charge	$Q_{rr}$		-	746	-	nC
Reverse Recovery Current	$I_{rrm}$		-	18	-	A
Reverse Recovery Energy	$E_{rec}$		-	122	-	$\mu\text{J}$
Diode peak rate of fall of reverse recovery current	$dI_{rr}/dt$		-	465	-	$\text{A}/\mu\text{s}$

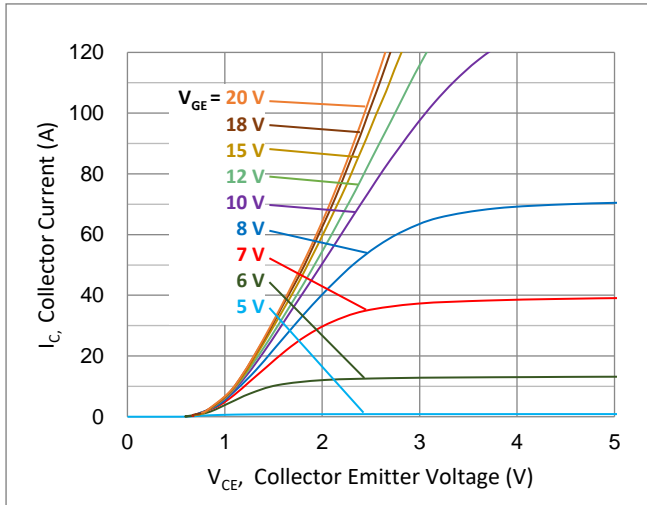


Fig.1 Typical Output Characteristic ( $T_{vj} = 25^\circ\text{C}$ )

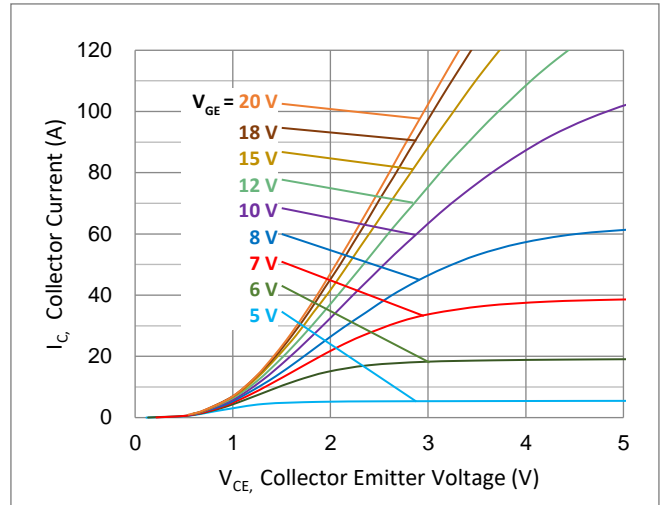


Fig.2 Typical Output Characteristic ( $T_{vj} = 175^\circ\text{C}$ )

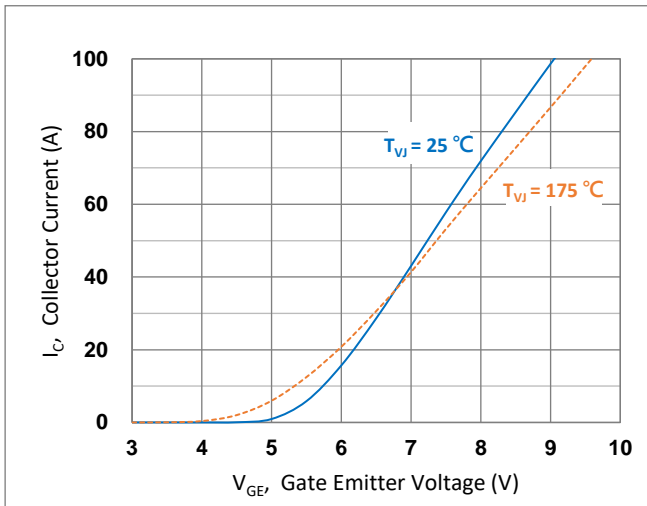


Fig.3 Typical Transfer Characteristic ( $V_{CE} = 20\text{V}$ )

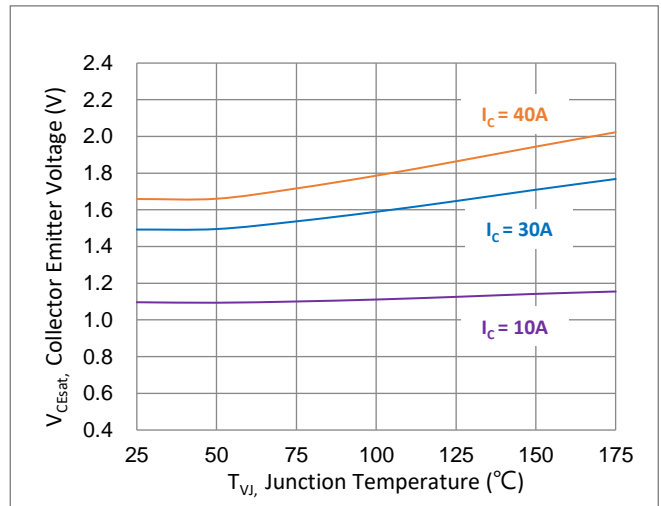


Fig.4  $V_{CEsat}$  vs.  $T_{vj}$

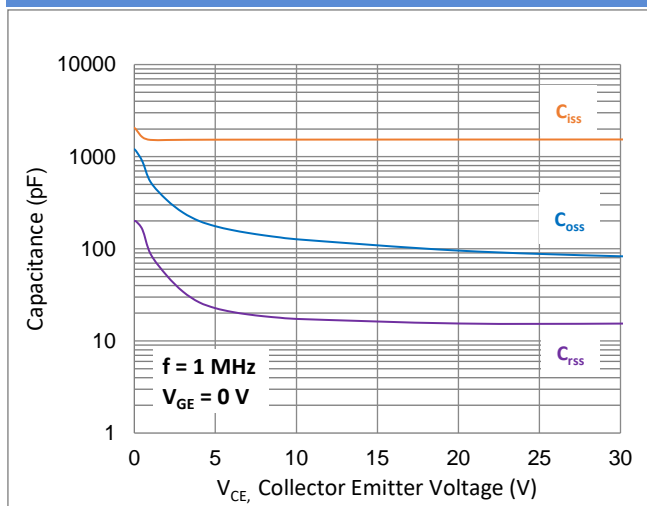


Fig.5 Typical Capacitance

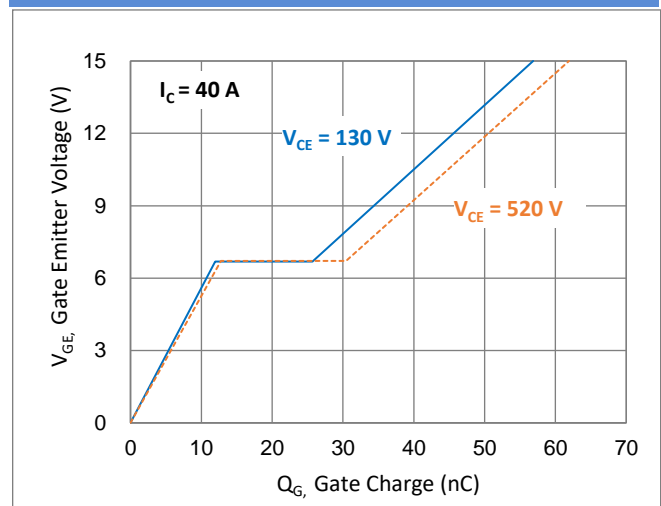
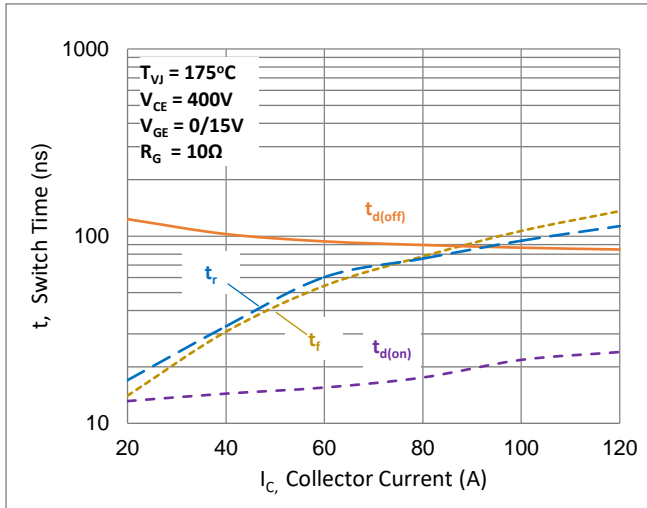
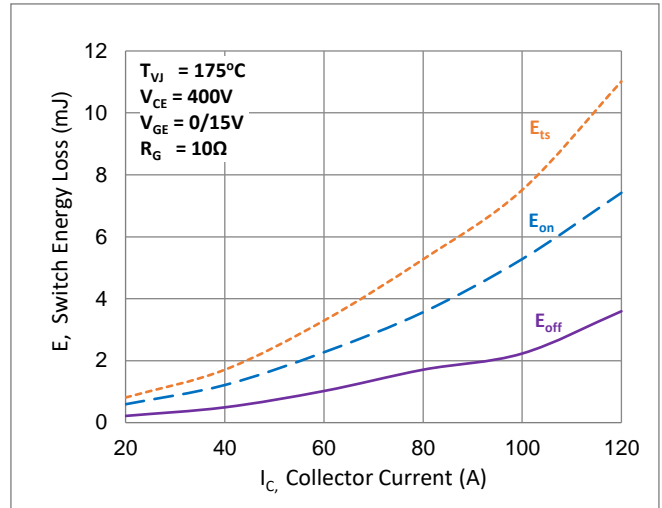


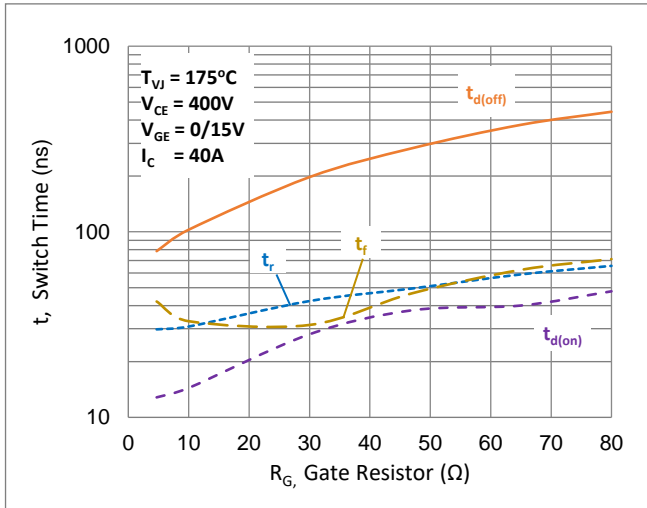
Fig.6 Typical Gate Charge



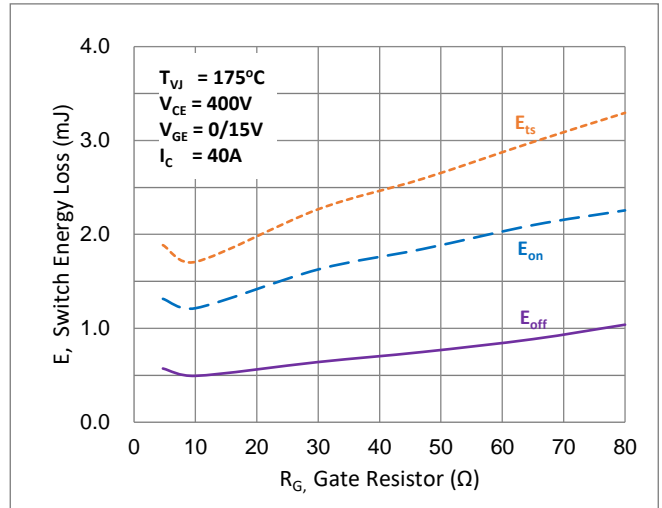
**Fig.7 Typical Switching Time vs.  $I_c$**



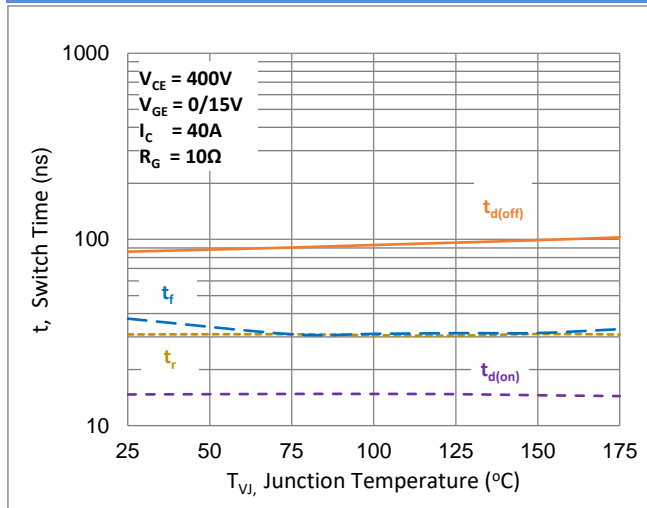
**Fig.8 Typical Switching Energy Loss vs.  $I_c$**



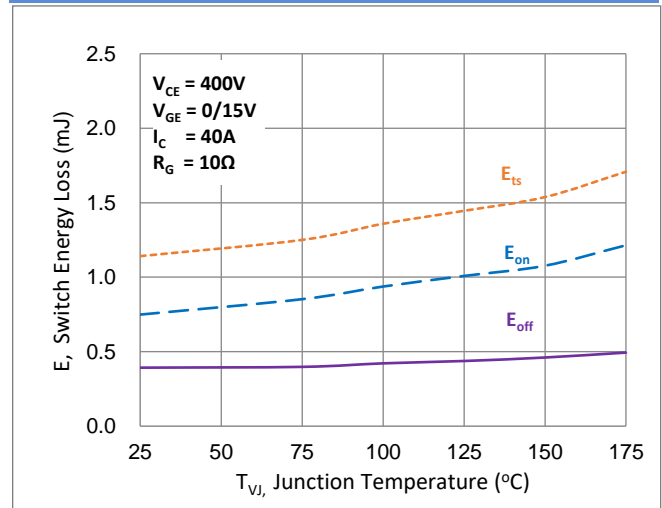
**Fig.9 Typical Switching Time vs.  $R_g$**



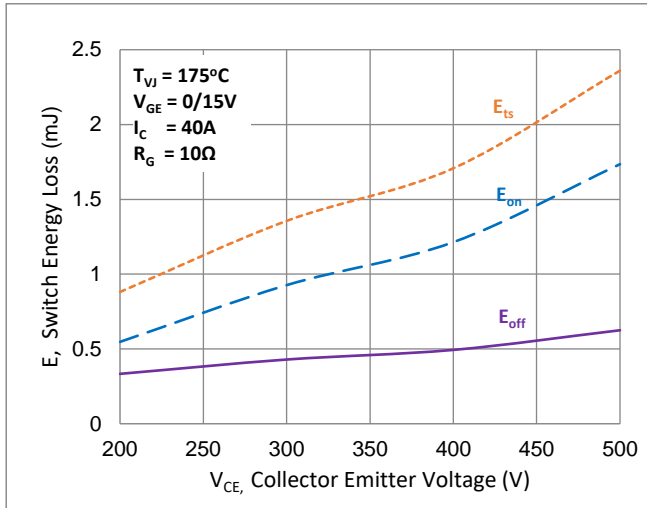
**Fig.10 Typical Switching Energy Loss vs.  $R_g$**



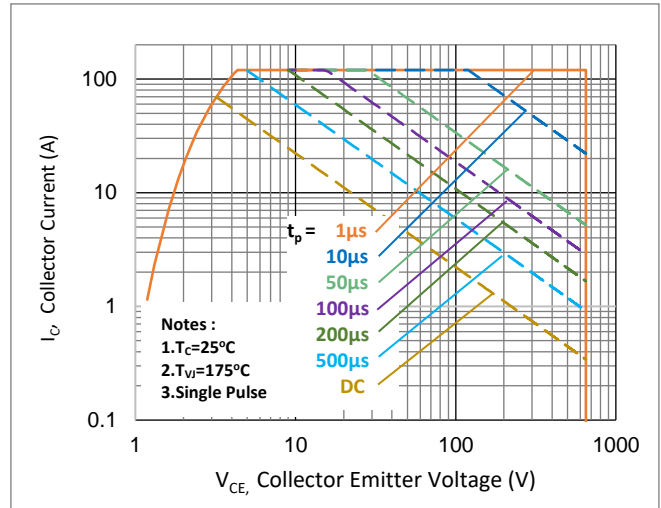
**Fig.11 Typical Switching Time vs.  $T_{vj}$**



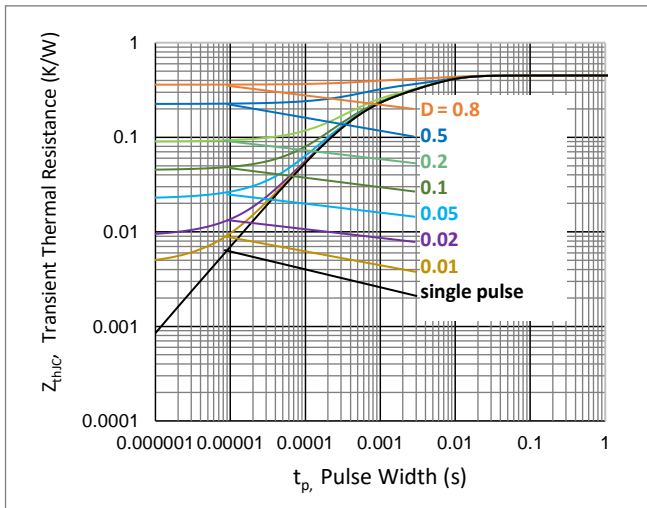
**Fig.12 Typical Switching Energy Loss vs.  $T_{vj}$**



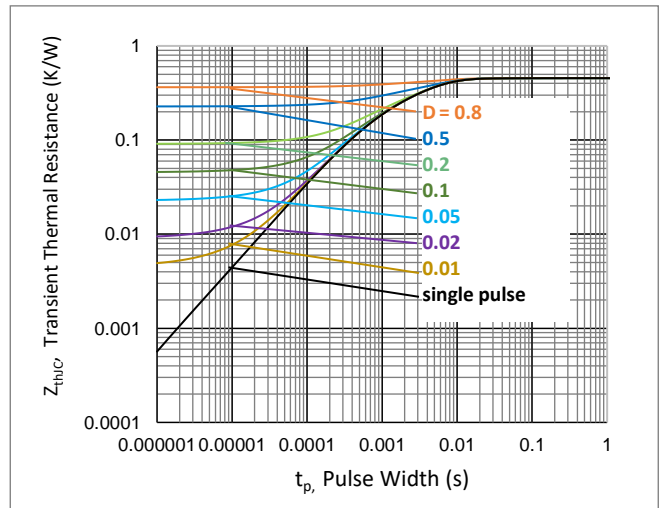
**Fig.13 Typical Switching Energy Loss vs.  $V_{CE}$**



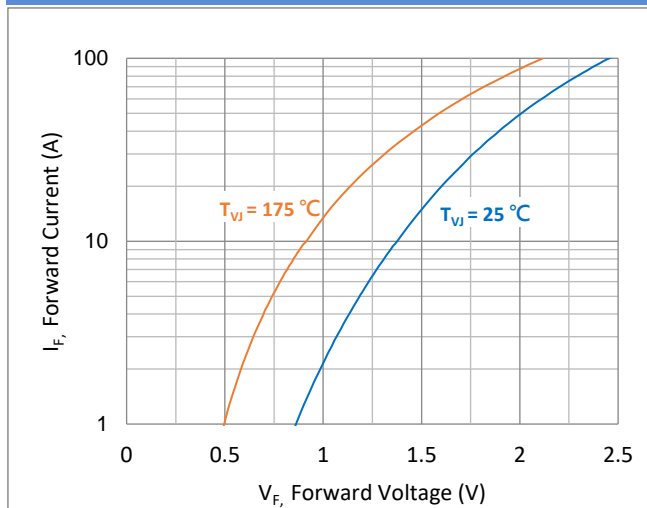
**Fig.14 SOA Characteristic**



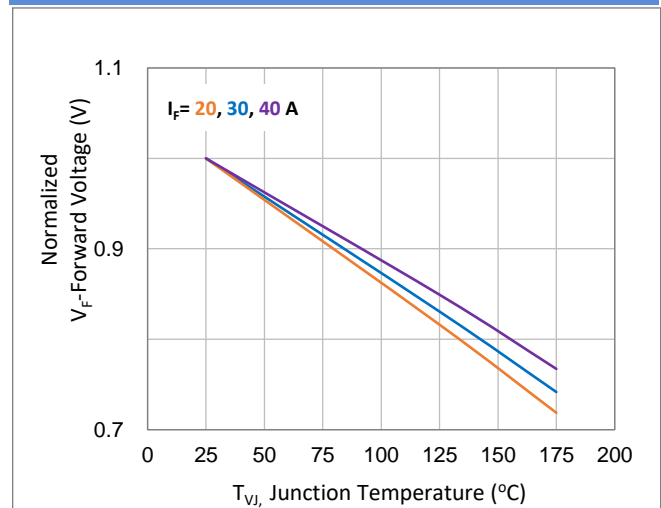
**Fig.15 IGBT Thermal Impedance**



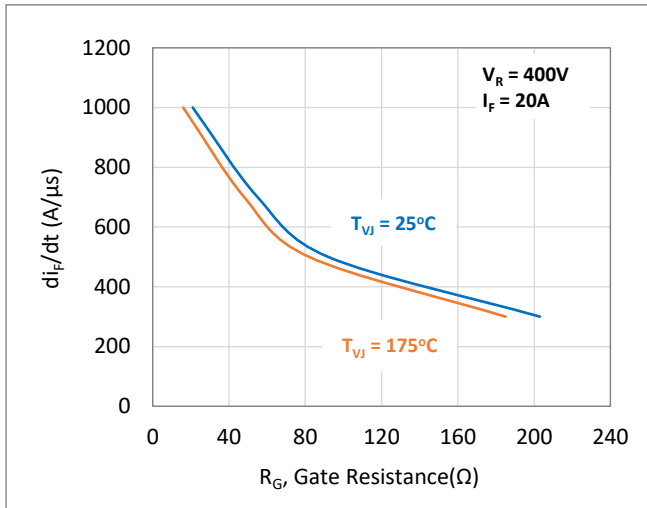
**Fig.16 Diode Thermal Impedance**



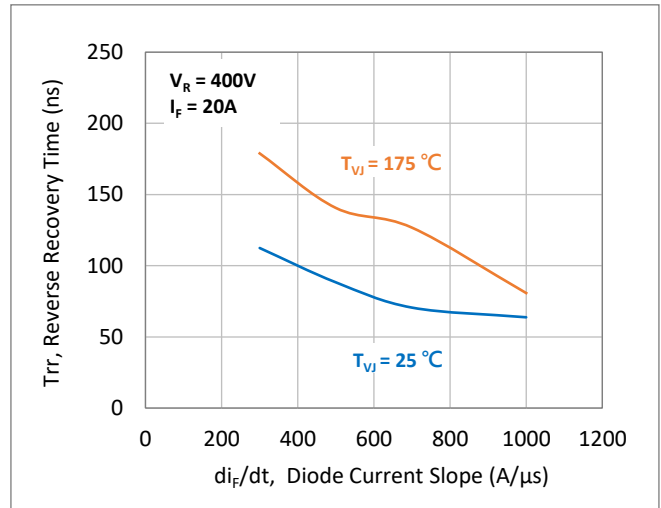
**Fig.17 Typical Diode Forward Characteristic**



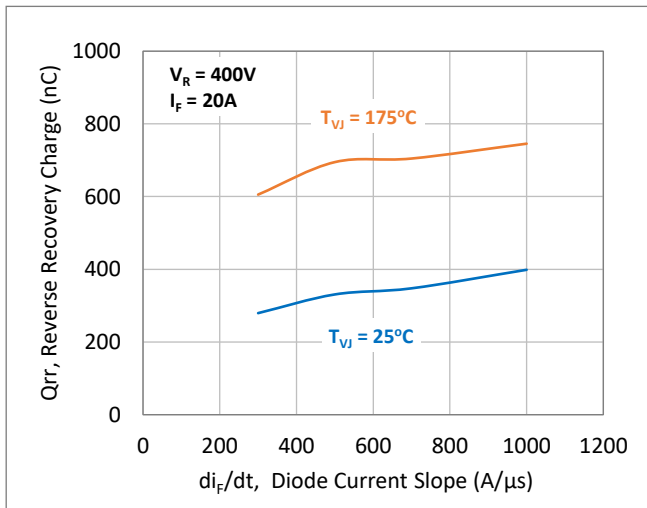
**Fig.18 Diode Forward Voltage vs.  $T_{vj}$**



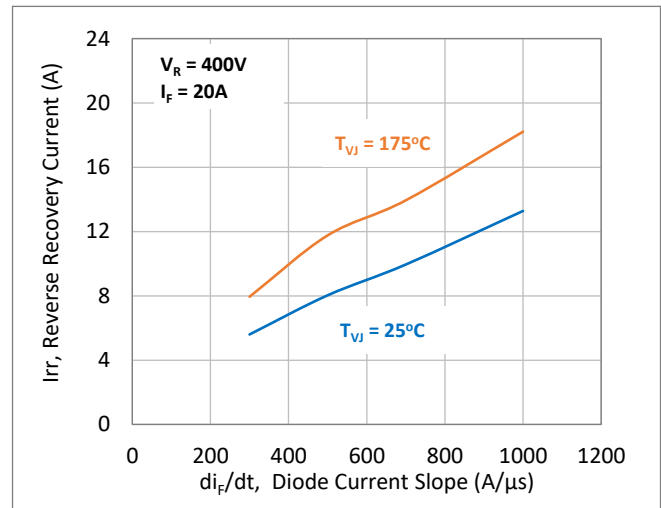
**Fig.19 Typical Diode Current Slope vs.  $R_G$**



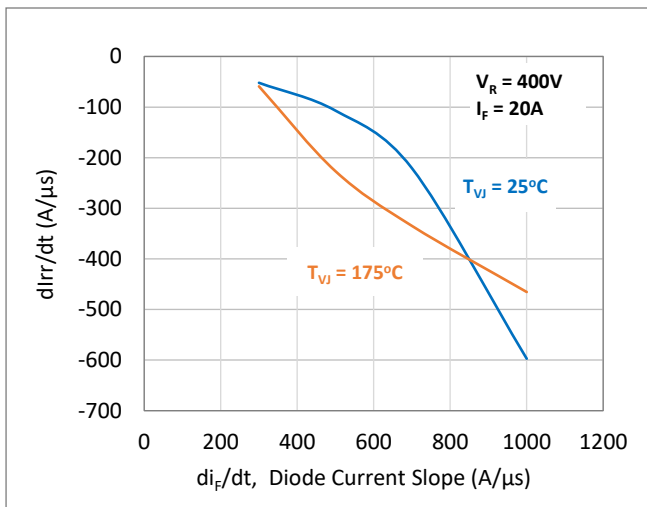
**Fig.20 Typical Reverse Recovery Time vs  $di_F/dt$**



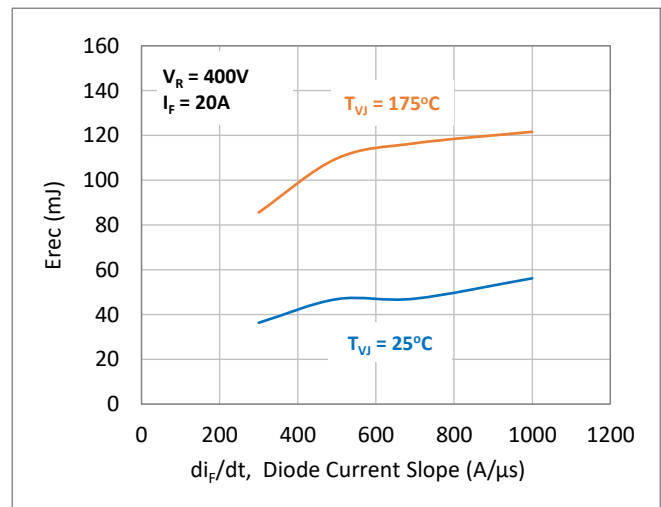
**Fig.21 Typical Reverse Recovery Charge vs  $di_F/dt$**



**Fig.22 Typical Reverse Recovery Current vs  $di_F/dt$**



**Fig.23  $dlrr/dt$  vs.  $di_F/dt$**



**Fig.24 Typical reverse energy losses vs.  $di_F/dt$**



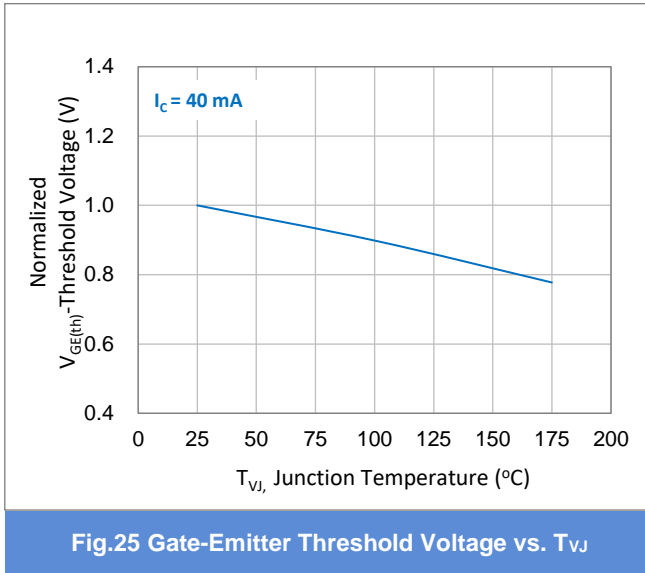
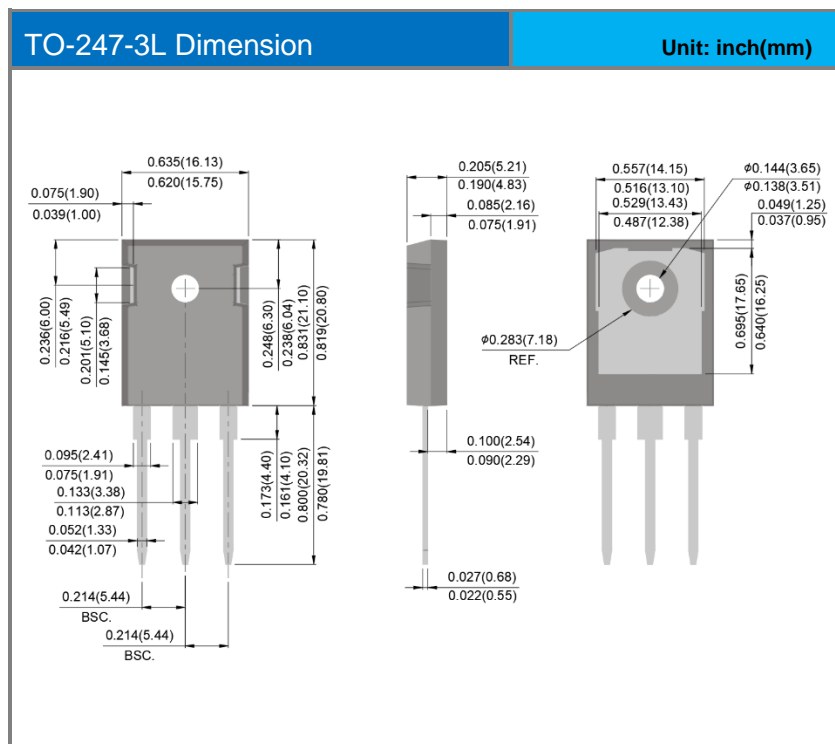


Fig.25 Gate-Emitter Threshold Voltage vs. T<sub>vj</sub>

**Product and Packing Information**

Part No.	Package Type	Packing Type	Marking
PTGH4065S1	TO-247-3L	30pcs / Tube	TGH4065S1

**Packaging Information**



## Disclaimer

- Reproducing and modifying information of the document is prohibited without permission from Panjit International Inc..
- Panjit International Inc. reserves the rights to make changes of the content herein the document anytime without notification. Please refer to our website for the latest document.
- Panjit International Inc. disclaims any and all liability arising out of the application or use of any product including damages incidentally and consequentially occurred.
- Panjit International Inc. does not assume any and all implied warranties, including warranties of fitness for particular purpose, non-infringement and merchantability.
- Applications shown on the herein document are examples of standard use and operation. Customers are responsible in comprehending the suitable use in particular applications. Panjit International Inc. makes no representation or warranty that such applications will be suitable for the specified use without further testing or modification.
- The products shown herein are not designed and authorized for equipments requiring high level of reliability or relating to human life and for any applications concerning life-saving or life-sustaining, such as medical instruments, transportation equipment, aerospace machinery et cetera. Customers using or selling these products for use in such applications do so at their own risk and agree to fully indemnify Panjit International Inc. for any damages resulting from such improper use or sale.
- Since Panjit uses lot number as the tracking base, please provide the lot number for tracking when complaining.